



Docket No.: 6515

IN THE UN **ES PATENT AND TRADEMARK OFFICE**

APPLICANT:

Masaki et al.

GROUP:

2621

SERIAL NO:

10/037,885

EXAMINÉR:

Unknown

FILED:

01/04/2002

FOR:

ADAPTIVE SENSITIVITY CONTROL, ON A PIXTEL-BY-PIXTEL BASIS,

FOR A DIGITAL IMAGER

Assistant Commissioner of Patents Washington, D.C. 20231

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APR 2 5 2002

Sir:

INFORMATION DISCLOSURE STATEMERS Innology Center 2600

In compliance with 37 C.F.R. §§1.56, 1.97, and 1.98, Applicant submits copies of the documents listed on the attached Form PTO-1449.

The Commissioner is authorized to charge Deposit Order Account No. 19-0079 for any further fee that is required.

Respectfully submitted,

Matthew E. Connors

Registration No. 33,298

Samuels, Gauthier & Stevens, LLP

225 Franklin Street, Suite 3300

Boston, Massachusetts 02110 Telephone: (617) 426-9180

Extension: 112

I hereby certify that this paper (along with any paper referred to as being attached or enclosed) is being deposited with the United States Postal Service on the date shown below with sufficient postage as first class mail in an envelope addressed to the Commissioner of Patents and Trademarks, Washington, D.C. 20231.

FORM PTO-1449 SAMUELS, GAUTHIER & STEP EQULP (Rev. 5/92) 225 Franklin Street, Boston, MA 02110 Telephone: (617) 426-9180

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STATEMENT BY APPLIC

6515 ATTORNEY DOCKET NO.

Masaki et al. APPLICANT

01/04/2002 FILING DATE

10/037,885 SERIAL NO.

<u>2621</u> GROUP

<u>Unknown</u> **EXAMINER**



U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE					RECE	VED
	AF					APR 2	2002
	AG					Technology C	anter 2600
	AH			. :			

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	ΑĪ						
	AJ						
	AK						
	AL						
	AM						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER INITIAL		
	AN	"A Stereo Vision System with Automatic Brightness Adaption," Keith G. Fife. Massachusetts Institute of Technology. May 1999. p. 1-141.
	AO	

EXAMINER

DATE CONSIDERED

EXAMINER:

Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.